

Notice of References Cited	Application/Control No. 10/631,818	Applicant(s)/Patent Under Reexamination LIN, JEN CHIEN	
	Examiner Jinhee J Lee	Art Unit 2831	Page 1 of 1

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	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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